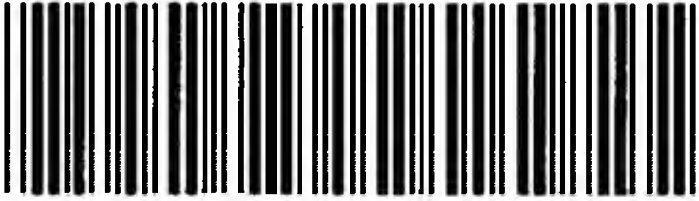


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/710,407	HOLCOMB ET AL.	
	Examiner	Art Unit	
	Hwei-Siu C. Payer	3724	

SEARCHED			
Class	Subclass	Date	Examiner
036	113.1	11-8-05	Payer
	114		
	301		
	302		
	303		
99	540		
	541		
	545		
D7	673		
	693		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR